

Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low RDS(ON)

Product Summary

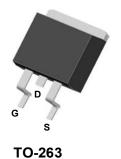


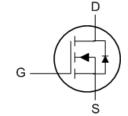
| BVDSS | RDSON | ID |
|-------|-------|------|
| 150V | 9.5mΩ | 120A |

Applications

- DC-DC Converters
- Power management functions
- Synchronous-rectification applications

TO&*' Pin Configuration





Absolute Maximum Ratings (T_A = 25°C, unless otherwise noted)

| Parameter | Symbol | Value | Unit | | |
|--|-----------------------|-----------------|-------|----|--|
| Drain-Source Voltage | V _{DS} | 150 | ٧ | | |
| Gate-Source Voltage | | V _{GS} | ±20 | V | |
| Continuous Durin Comment | T _C =25°C | | 120 | А | |
| Continuous Drain Current | T _C =100°C | ID | 56 | | |
| Pulsed Drain Current ¹ | Ідм | 352 | Α | | |
| Single Pulse Avalanche Energy ² | | EAS | 204.8 | mJ | |
| Total Power Dissipation | T _C =25°C | P _D | 178.6 | W | |
| Operating Junction and Storage Temperature | ТЈ, Тѕтс | -55 to 150 | °C | | |

Thermal Characteristics

| Parameter | Symbol | Value | Unit |
|--|------------------|-------|------|
| Thermal Resistance from Junction-to-Ambient ³ | ReJA | 52 | °C/W |
| Thermal Resistance from Junction-to-Case | R _{θJC} | 0.7 | °C/W |



Electrical Characteristics (T_J = 25°C, unless otherwise noted)

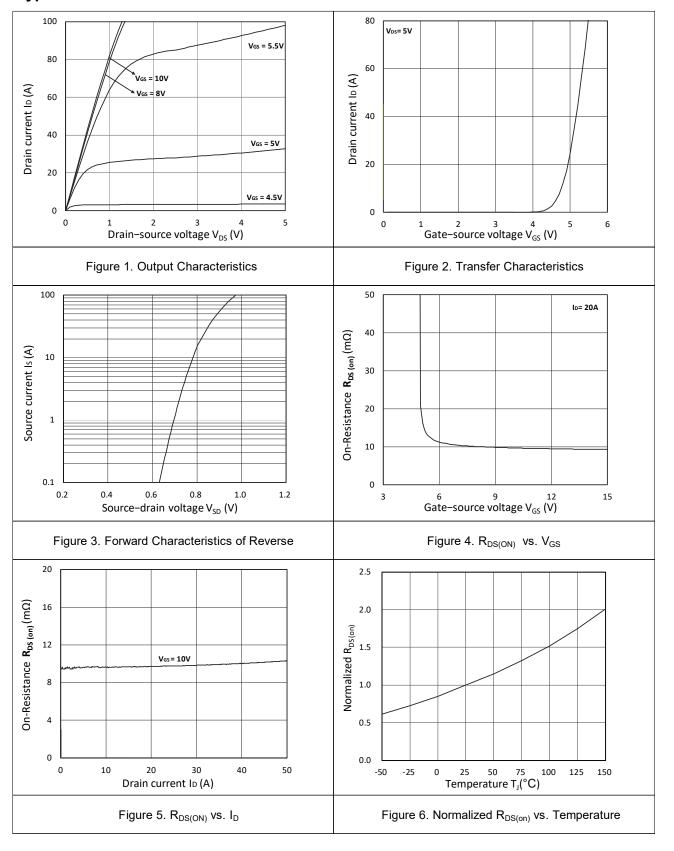
| Parameter | | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|---|------------------------------|---------------------------|---|------|------|------|------|
| Static Characteristics | Static Characteristics | | | | | | |
| Drain-Source Breakdown Vo | oltage | V _{(BR)DSS} | V _{GS} = 0V, I _D = 250µA | 150 | - | - | V |
| Gate-body Leakage Current | | I _{GSS} | V _{DS} = 0V, V _{GS} = ±20V | - | - | ±100 | nA |
| Zero Gate Voltage Drain | T _J =25°C | | V _{DS} = 150V, V _{GS} = 0V | - | - | 1 | μА |
| Current | T _J =100°C | - I _{DSS} | | - | - | 100 | |
| Gate-Threshold Voltage | | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 2 | 3 | 4 | V |
| Drain-Source On-Resistance | e ⁴ | R _{DS(on)} | V _{GS} = 10V, I _D = 20A | - | 9.5 | 11.5 | mΩ |
| Forward Transconductance | 1 | g fs | V _{DS} = 10V, I _D = 20A | - | 69 | - | S |
| Dynamic Characteristic | S ⁵ | | | • | | • | |
| Input Capacitance | | C _{iss} | | - | 3310 | - | |
| Output Capacitance | | Coss | $V_{DS} = 75V, V_{GS} = 0V,$ f = 1MHz | - | 268 | - | pF |
| Reverse Transfer Capacitar | Reverse Transfer Capacitance | | | - | 9.4 | - | |
| Gate Resistance | | Rg | f = 1MHz | - | 3.2 | - | Ω |
| Switching Characteristi | CS ⁵ | | | • | | • | |
| Total Gate Charge | | \mathbf{Q}_{g} | | - | 45 | - | |
| Gate-Source Charge | | Qgs | $V_{GS} = 10V$, $V_{DS} = 75V$, $I_{D} = 20A$ | - | 15 | - | nC |
| Gate-Drain Charge | | Q _{gd} | | - | 8.5 | - | |
| Turn-On Delay Time | | t _{d(on)} | | - | 16 | - | |
| Rise Time Turn-Off Delay Time | | t _r | $V_{GS} = 10V, V_{DD} = 75V,$ $R_{G} = 3\Omega, I_{D} = 20A$ | - | 12 | - | ns |
| | | t _{d(off)} | | - | 30 | - | |
| Fall Time | | t _f | | - | 18 | - | |
| Body Diode Reverse Recovery Time | | t _{rr} | | - | 76 | - | ns |
| Body Diode Reverse Recovery Charge | | Qrr | - I _F =20A, dl/dt=100A/μs | - | 182 | - | nC |
| Drain-Source Body Diode Characteristics | | | | | | | |
| Diode Forward Voltage ⁴ | | V _{SD} | I _S = 20A, V _{GS} = 0V | - | - | 1.2 | V |
| Continuous Source Current | T _C =25°C | Is | - | - | - | 120 | Α |

Notes:

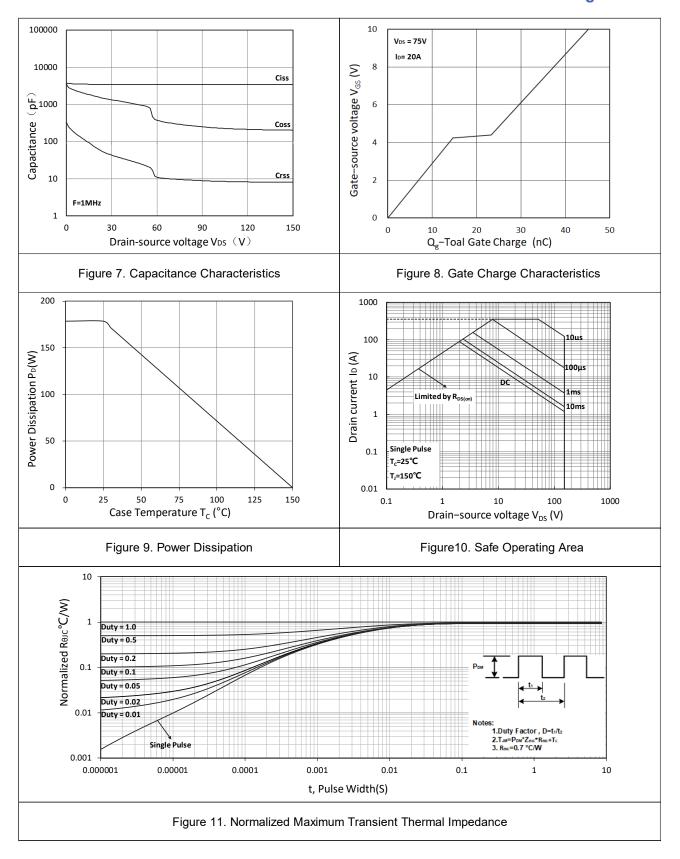
- 1. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150°C
- 2. The EAS data shows Max. rating . The test condition is V_{DD} =50V, V_{GS} =10V,L=0.4mH, I_{AS} =32A.
- 3. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
- 4. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 5. This value is guaranteed by design hence it is not included in the production test.



Typical Characteristics







Test Circuit

N-Ch 150V Fast Switching MOSFETs

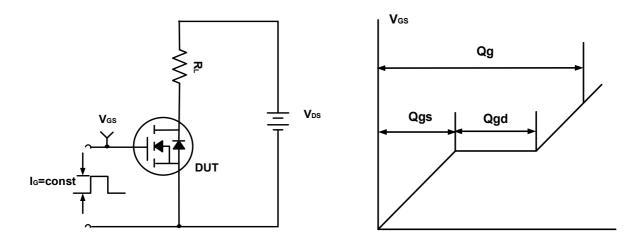


Figure A. Gate Charge Test Circuit & Waveforms

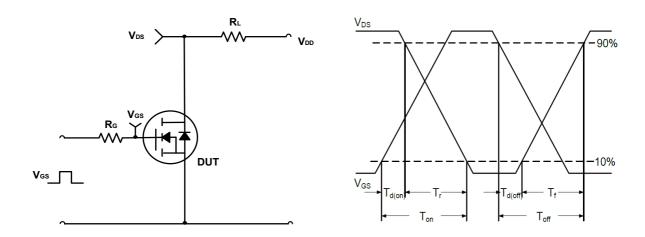


Figure B. Switching Test Circuit & Waveforms

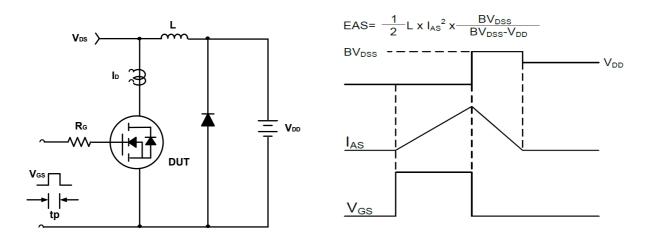
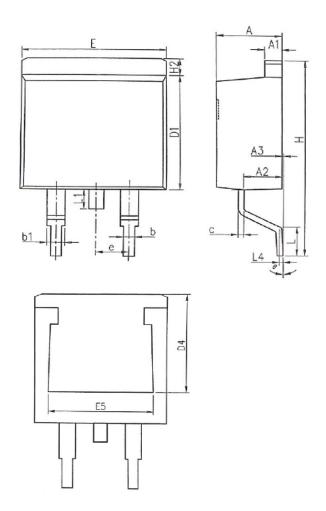


Figure C. Unclamped Inductive Switching Circuit & Waveforms



Mechanical Dimensions for TO-263



COMMON DIMENSIONS

| | MM | | | |
|--------|----------|-------|--|--|
| SYMBOL | MIN | MAX | | |
| Α | 4.37 | 4.89 | | |
| A1 | 1.17 | 1.42 | | |
| A2 | 2.20 | 2.90 | | |
| A3 | 0.00 | 0.25 | | |
| b | 0.70 | 0.96 | | |
| b1 | 1.17 | 1.47 | | |
| С | 0.28 | 0.60 | | |
| D1 | 8.45 | 9.30 | | |
| D4 | 6.60 | - | | |
| Е | 9.80 | 10.40 | | |
| E5 | 7.06 | - | | |
| е | 2.54BSC | | | |
| Н | 14.70 | 15.70 | | |
| H2 | 1.07 | 1.47 | | |
| L | 2.00 | 2.80 | | |
| L1 | - | 1.75 | | |
| L4 | 0.254BSC | | | |
| θ | 0° | 9° | | |